IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In application of:	§	Attorney Docket No. 26114.13
In application of: Robert Malek, et al.	§	,
	§	Customer No. 27683
Serial No. 10/796,645	§	
	§	Group Art Unit: 2881
Filed: March 9, 2004	§	
	§	Examiner: Anthony G. Quash
For: MASS SPECTROMETER	§	
	§	Confirmation No. 2185

Mail Stop Amendment Commissioner For Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

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Karen L. Underwood

FIFTH INFORMATION DISCLOSURE STATEMENT

Pursuant to the provisions of 37 C.F.R. §§ 1.56, 1.97 and 1.98, Applicants are filing this Information Disclosure Statement in order to cite some documents that may be material to the examination of this patent application, including a PCT Search Report from a related PCT application, and some art cited in that PCT Search Report. Each cited document is listed on enclosed Form PTO-1449 (modified), and Applicants are enclosing a copy of each cited document.

This Information Disclosure Statement is being filed under 37 C.F.R. §1.97(c), or in other words after mailing of a first Office Action on the merits, but before mailing of a communication that closes prosecution on the merits. In fact, this Information Disclosure Statement is being filed concurrently with a Response to the first Office

Action on the merits. An enclosed check includes the PTO fee of \$180.00 for submission of an Information Disclosure Statement at this point in the examination process.

It is respectfully requested that the Examiner (1) consider the documents cited on enclosed Form PTO-1449, (2) initial Form PTO-1449 for each listed document, and then (3) return a copy of the initialed PTO-1449 with the next PTO communication.

Date: 17 MARCH 2006 HAYNES AND BOONE, LLP

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Respectfully submitted,

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Enclosures: Form PTO-1449, and one copy of each listed document

Check (\$180.00)

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Form PTO-1449 (modified)	U. S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Complete if Known
, ,		Application Number	10/796,645
INFO	RMATION DISCLOSURE	Filing Date	March 9, 2004
STAT	TEMENT BY APPLICANTS	Applicant(s)	Robert Malek, et al.
	se as many sheets as necessary)	Art Unit	2881
	MAR 2 0 2006	Examiner Name	Anthony G. Quash
SHEET	1 OF 16	Attorney Docket Number	26114.13
<u> </u>	TRABENA		

U. S. PATENT DOCUMENTS				
Examiner's Initials	Cite No.	Document Number	Publication Date	Name of Patentee or Applicant of Cited Document
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FOREIGN PATENT DOCUMENTS					
Examiner's Initials	Cite No.	Foreign Patent Document (Country Code - Number - Kind)	Publication Date	Patentee or Applicant of Cited Document	Translation
			<u> </u>		

Examiner's	Cite	Include name of the author, title of the article, title of the item, date, page(s), volume-issue number(s),
Initials	No.	publisher, city/country where published
		PCT Search Report (Form PCT/ISA/ 210) issued by the European Patent Office in PCT Application No.
		PCT/EP2004/002486, 7 pages.
		Senko, Michael W., et al., "External Accumulation of Ions for Enhanced Electrospray Ionization Fourier
		Transform Ion Cyclotron Resonance Mass Spectrometry", Journal of the American Society for Mass
		Spectrometry, Vol. 8, pages 970-976, 1997.
		Alford, J.M., et al., "Metal Cluster Ion Cyclotron Resonance: Combining Supersonic Metal Cluster Beam
		Technology with FT-ICR", International Journal of Mass Spectrometry and Ion Processes, Vol. 72,
		pages 33-51, 1986.
		Senko, Michael W., et al., "Electrospray Ionization Fourier Transform Ion Cyclotron Resonance at 9.4 T",
		Rapid Communications in Mass Spectrometry, Vol. 10, pages 1824-1828, 1996.
		Beu, Steven C., "Fourier-Transform Electrospray Instrumentation for Tandem High-Resolution Mass
		Spectrometry of Large Molecules", Journal of the American Society for Mass Spectrometry, Vol. 4, pages 557-565, 1993.

Examiner	Date	
Signature	Considered	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.

R-131183.1 Customer No. 000027683